### APPROVAL SPECIFICATIONS

Title. HDMI USB CONNECTOR

Product Model. HDMI-001C

Customer's Part NO.

Customer's Model:

### Customer's Approval Requested.

Please return this copy as a certification of your approval.

Checked by: Date:

Approved by: Date:

APPROVE	REVIEW	POLT		
王凯	林永坚	陈旺		

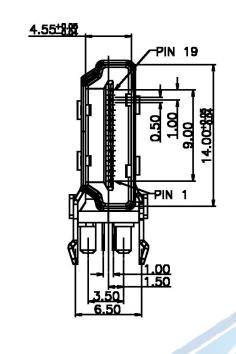
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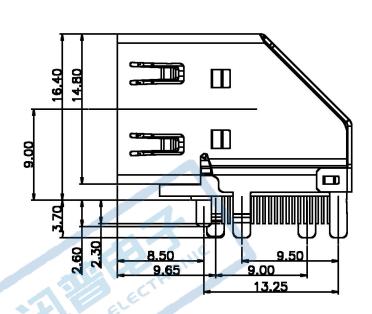


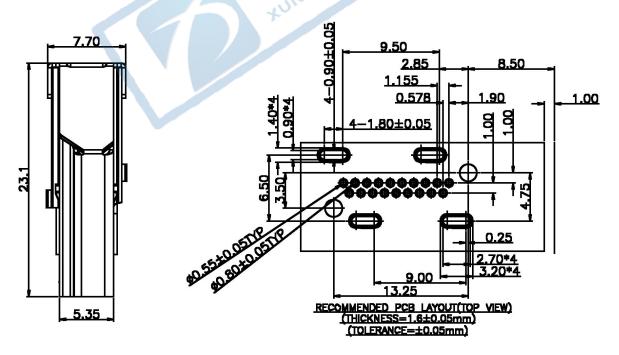
### **APPROVAL SPECIFICATIONS**

CUSTOMER	CUSTOMER'S P/N	GYE'S P/N	PRODUCT	REVISION					
		HDMI-001C	HDMI USB CONNECTOR						

产品符合ROHS







General tolerance: ±0.2mm

APPROVE BY	王凱 10.05.09	CHECKED BY	李永坚 10.05.09	PRPARE BY	陈旺 10.05.09

# 東莞市訊普電子科技有限公司

## HDMI系列產品SPEC

	TEST ITEM	REQUIREMENT					
1	Examination of Product	Meets requirements of product drawing. No physical damage.	Visual inspection.				
2	Operating Temperature	-55°C ~+85°C					
3	Storage Temperature	-20°C ~+85°C					
		ELECTRICAL REQUIREMEN	T				
4	Rating Voltage	40VAC max	on any signal pin with respect to the shield				
5	Rating Current	0.5A Min type A/B/C/E; 0.3A Min type D  55°C, maximum ambient 85°C, maximum ambient 85°C					
6	Contact Resistance	[30] m Ohm Max(Initial) [50] m Ohm Max(Final)	Subject mated contacts assembled in housing to 20mV Max open circuit at 150mA Max. EIA-364-23.				
7	Dielectric withstanding Voltage	No breakdown	[500]VAC(Type A/B/C/E) [150]VAC(Type I) for 1minute Test between adjacent circuits of unmated connector. EIA-364-20C				
8	Insulation Resistance	[100] M Ohm Min.(unmated) [10] M Ohm Min.(mated)	hpressed voltage 500 VDC(unmated) 50VDC(mated). Test between adjacent circuits Funmated connector. EIA-364-21C.				
9	Temperature Rising	30°C Max. Under loaded rating current	Contact series-wired, apply test current of loaded rating current to the circuit, and measure the temperature rising by probing on soldered areas of contacts, after the temperature becomes stabilized deduct ambient temperature from the measured value.				
		Mechanical Requirement					
10	Connector Mating Force	<u>44.1</u> N Max	Operation Speed: [25] mm/min. Measure the force required to mate connector. EIA-364-13				
11	Connector Unmating Force	9.8N-39.2N type A 7N-25N type C 5N-25N type D 3N-25N after 5000cycles	Operation Speed: [25] mm/min. Measure the force required to unmate connector. EIA-364-13				
12	Durability	30m ohms Max change from initial per contact pair	Automatic cycling to 10000 cycles(type A) 5000cycles(type C and D) Rate:100±50 cycles per hour. EIA-364-09C				
13	Vibration	No discontinuity at 1 $\mu$ s or longer(each contact) when continuity is tested per ANSI/EIA-364-46	ANSI/EIA-364-28, Condition III, Method 5A, 15 minute/axis				
14	Mechanical Shock	No discontinuity at 1 $\mu$ s or longer(each contact) when continuity is tested per ANSI/EIA-364-46	ANSI/EIA-364-27 Condition A(specified pulse)				
15	Solder ability	At least 95% of the immersed area shall be covered with new solder	1)Temperature of fused solder: 245±5°C. 2)Dipping time:5+0.5s EIA 364-52				

## 東莞市訊普電子科技有限公司 HDMI系列產品SPEC

	TEST ITEM		RE	EQUIREN	MENT							
16	Resistance to Solder Heat	Forming resin shall not be distorted, and terminations shall not be separated.				1) Depth of dipping termination: the distance between the mounting surface and solder surface shall be 1 mm to 2mm. 2) Temperature: 245±5°C. 3) Dipping time: 10±1s Socket EIA 364-56						
17	Thermal Shock	No physical damage to the samples and LLCR-50 m $\Omega$ max per contact					Mated connectors exposed to 10 cycles between – 55°C to 85°C, 30 minutes duration at both temperature extremes EIA 364-32					
18	Steady State Humidity	Expose mated connectors to a temperature of ±2°C with relative humidity of 90-95% for 16 hours Min(seven complete cycles). Remove surface moisture and air dry for 24 hours. prior to measurement. EIA 364-31						for 168 nove				
19	Temperature Life (Heat Aging)	30m ohms Max change from initial per contact pair ANSI/EIA-364-17 Condition 4 105°C for 250 hours, Method A, mated							for 250			
20	Salt Spray	Mated connector expose to 5% salt concentration for 12 hours at temperature 35+2 $\Omega$ max per contact $\mathbb{C}$ . After the test specimens shall be washed with running water and dried naturally EIA 364-26										
			Product	t Qualifica	ation and I	Requalificat	on test					
					JP	Test C	roup					
Tes	st or Examination	A	В	C	T D	Е	F	G	Н	I	J	
				هرو		Test Seque	nce (a)		1			
Exam	ination of Product	1, 7	1, 9	1, 6	1, 5	1, 5	1, 5	1, 5	1, 3	1, 3	1, 3	
	ct Resistance		2, 8	2, 5	2, 4	2, 4	2, 4	2, 4				
	tric withstanding	3, 6										
	Insulation Resistance											
	erature Rising								2			
	g Force		3, 7									
	ting Force		4, 6									
Durab	•		5	_								
	Vibration			3	<del> </del>							
Mechanical Shock				4	<del>                                     </del>					-		
Solderability										2	2	
	Resistance to Soldering				2					2		
Thermal Shock		4			3	2				-		
	lity Temperature	4				3	2					
	erature Life				1		3	2				
Salt S	pray	<u> </u>	1	1	1		1	3	<u> </u>	I	I	
	備注    無客戶指定增加測試項目外,依照此標准進行產品可靠性評估。											

審核:皮洪斌 制定: 何星

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